Maplesemi

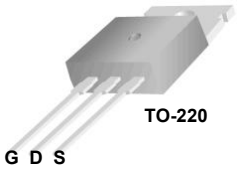
SLP65R170E7 / SLF65R170E7
650V N-Channel MOSFET

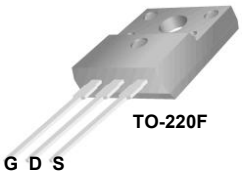
General Description

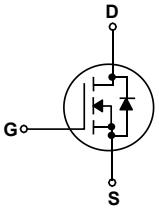
This Power MOSFET is produced using Maple semi's advanced trench MOSFET technology.
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies.

Features

- 22A, 650V, $R_{DS(on)}$ =170mΩ@V_{GS} = 10 V
- Low gate charge(typ. Qg = 30.2nC)
- High ruggedness Ultra
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability







Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter		SLP65R170E7 / SLF65R170E7	Units
V_{DSS}	Drain-Source Voltage		650	V
I_D	Drain Current - Continuous (T_C = 25℃)		22 *	A
	- Continuous (T_C = 100℃)		12*	A
I_{DM}	Drain Current - Pulsed	(Note 1)	57 *	A
V_{GSS}	Gate-Source Voltage		±30	V
EAS	Single Pulsed Avalanche Energy	(Note 2)	985	mJ
I_{AR}	Avalanche Current	(Note 1)	4	A
E_{AR}	Repetitive Avalanche Energy	(Note 1)	1.62	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	20	V/ns
	MOSFET dv/dt		100	
P_D	Power Dissipation (T_C = 25℃)		36	W
	- Derate above 25℃		0.29	W/℃
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	℃
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		260	℃

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	SLP65R170E7 / SLF65R170E7	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	3.5	℃/W
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	-	℃/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	℃/W

Electrical Characteristics

T_C = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 1mA	650	--	--	V
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 1mA,TJ = 150℃	650	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 650 V, V_{GS} = 0 V	--	--	1	uA
		V_{DS} =480 V, T_C = 125℃	--	2	--	uA
I_{GSSF}	Gate-Body Leakage Current, Forward	V_{GS} = 30 V, V_{DS} = 0 V	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	V_{GS} = -30 V, V_{DS} = 0 V	--	--	-100	nA
On Characteristics						
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 1.7mA	2.5	--	4.5	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 10 V, I_D = 10 A	--	150	170	mΩ
Dynamic Characteristics						
C_{iss}	Input Capacitance	V_{DS} = 400 V, V_{GS} = 0 V, f = 250KHz	--	1240	--	pF
C_{oss}	Output Capacitance		--	34	--	pF
C_{rss}	Reverse Transfer Capacitance		--	--	--	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	V_{DS} = 400 V, I_D = 10 A, R_G = 10 Ω,VGS = 10 V (Note 4, 5)	--	12	--	ns
t_r	Turn-On Rise Time		--	8	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	53	--	ns
t_f	Turn-Off Fall Time		--	10	--	ns
Q_g	Total Gate Charge	V_{DS} = 400 V, I_D = 10 A, V_{GS} = 10 V (Note 4, 5)	--	30.2	--	nC
Q_{gs}	Gate-Source Charge		--	5.8	--	nC
Q_{gd}	Gate-Drain Charge		--	15.4	--	nC
R_G	Gate Resistance	f = 1MHz		1.3		Ω
Drain-Source Diode Characteristics and Maximum Ratings						
I_S	Maximum Continuous Drain-Source Diode Forward Current		--	--	22	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current		--	--	57	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 10 A	--	--	1.2	V
t_{rr}	Reverse Recovery Time	V_{DD} = 400 V, I_S = 10A, dI_F / dt = 100 A/us (Note 4)	--	274	--	ns
Q_{rr}	Reverse Recovery Charge		--	3.33	--	uC

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L=79mH I_{AS} = I_D, V_{DD} = 50V, R_G = 25Ω, Starting T_J = 25°C
3. $I_{SD} \leq I_D$ di/dt ≤ 200A/us, $V_{DD} \leq$400, Starting T_J = 25°C
4. Pulse Test : Pulse width ≤ 300us, Duty cycle ≤ 2%
5. Essentially independent of operating temperature

Typical Characteristics

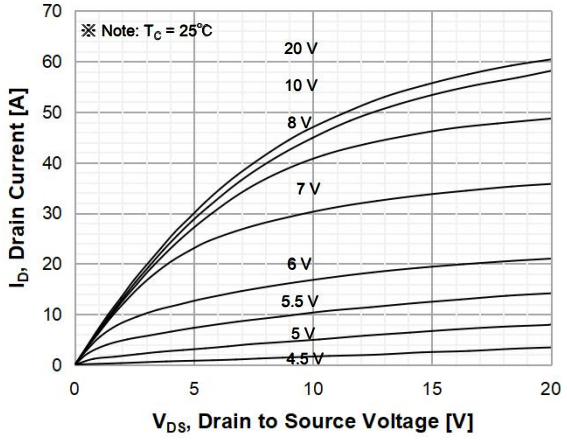


Figure 1. On-Region Characteristics

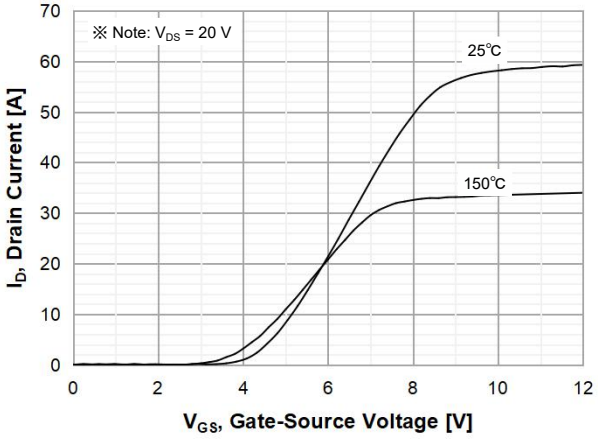


Figure 2. Transfer Characteristics

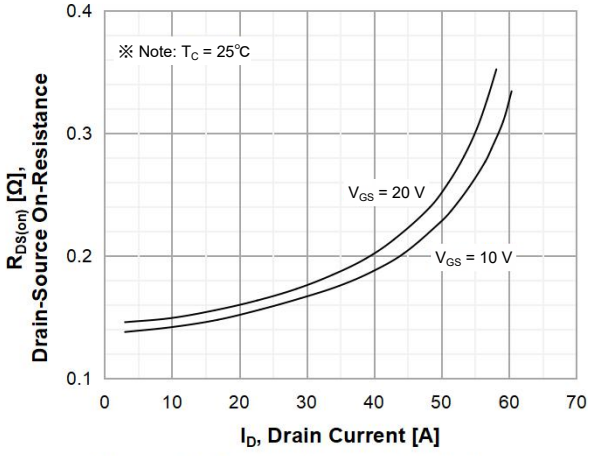


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

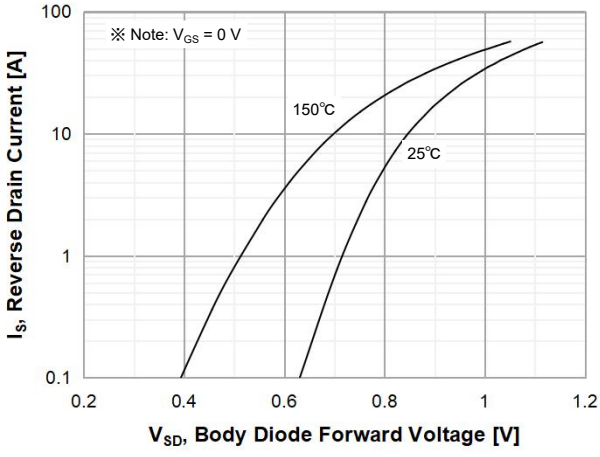


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

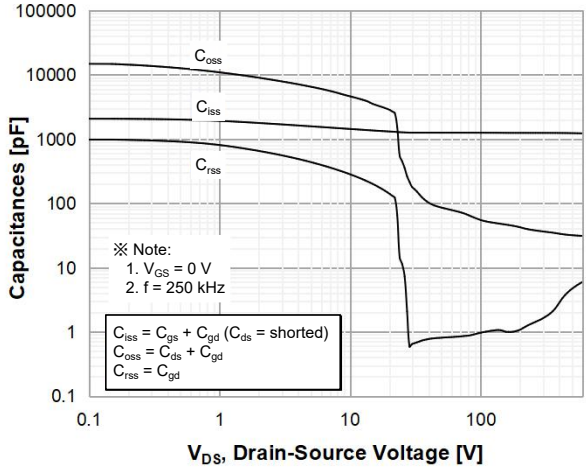


Figure 5. Capacitance Characteristics

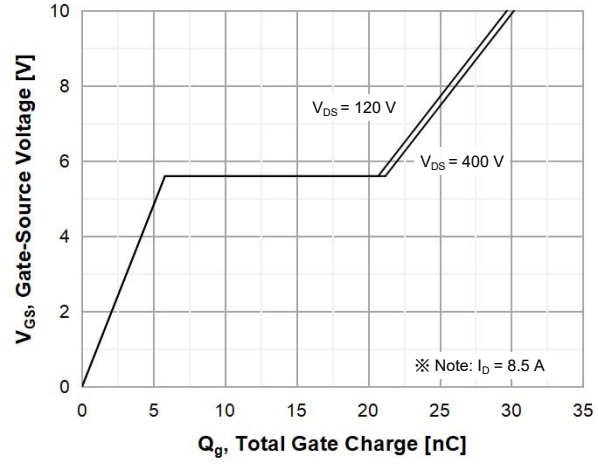


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

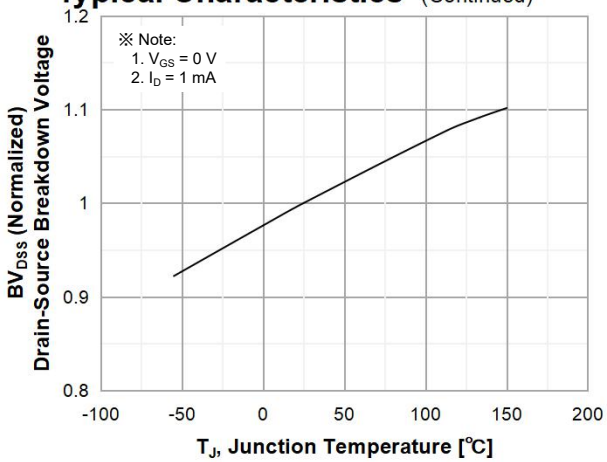


Figure 7. Breakdown Voltage Variation vs Temperature

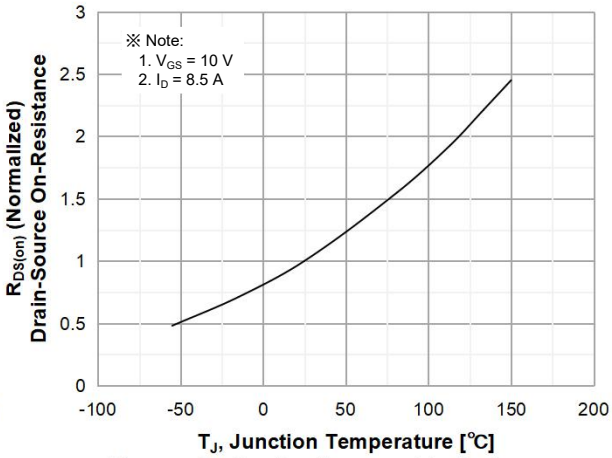


Figure 8. On-Resistance Variation vs Temperature

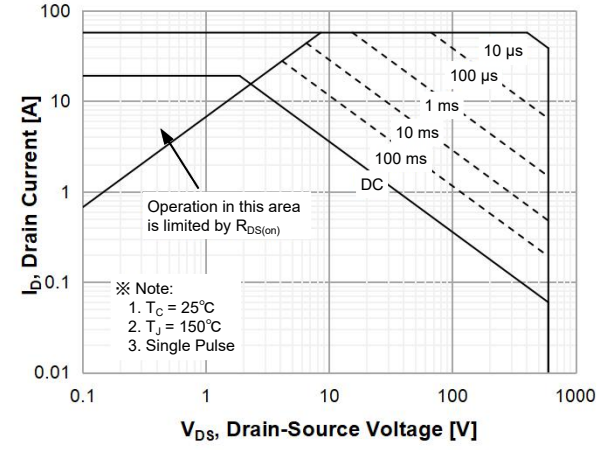


Figure 9. Maximum Safe Operating Area

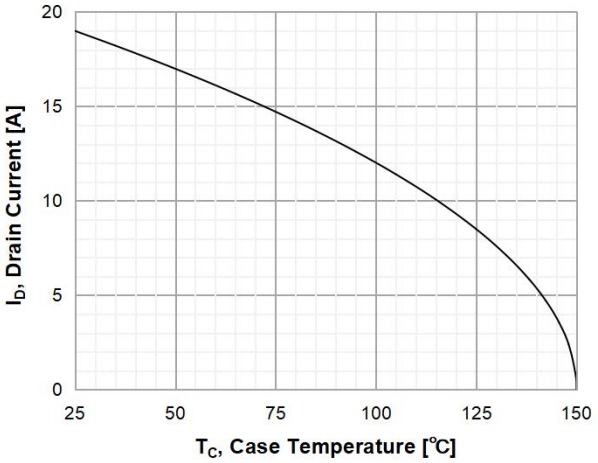


Figure 10. Maximum Drain Current vs. Case Temperature

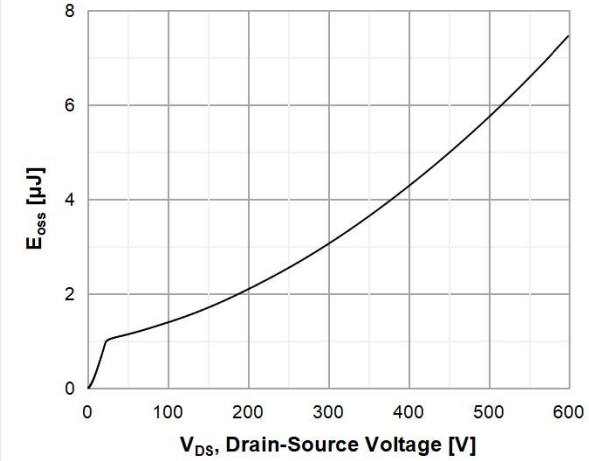


Figure 11.E_{oss} vs. Drain to Source Voltage

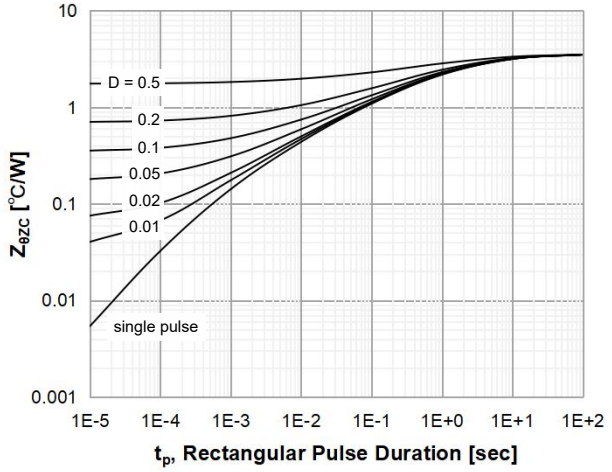
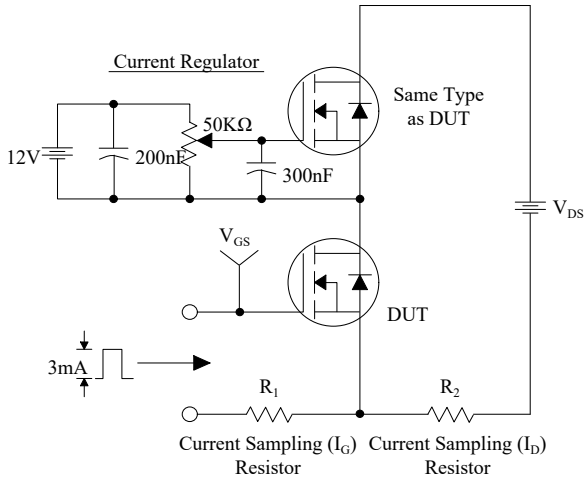
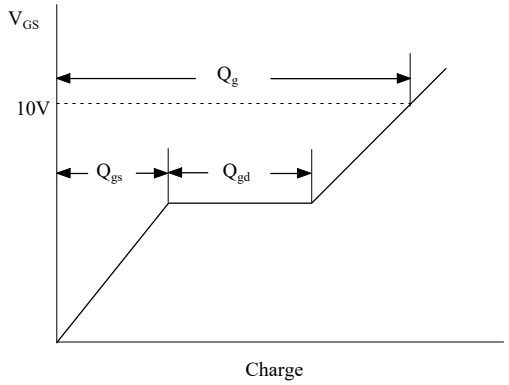


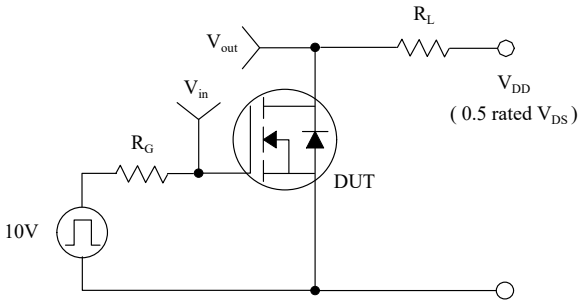
Figure 12.Transient Thermal Response Curve

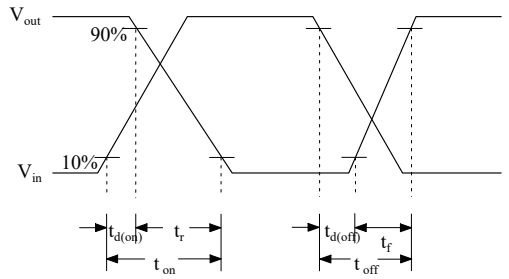
Gate Charge Test Circuit & Waveform



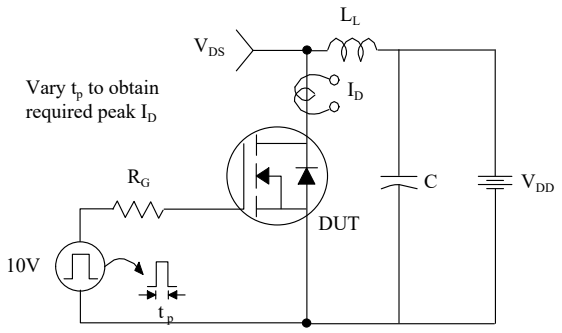


Resistive Switching Test Circuit & Waveforms

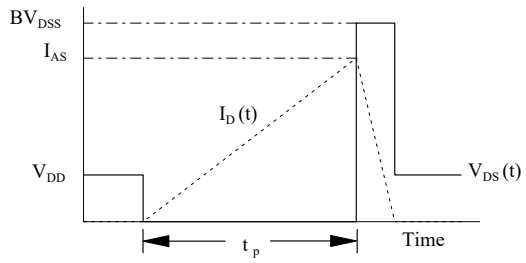




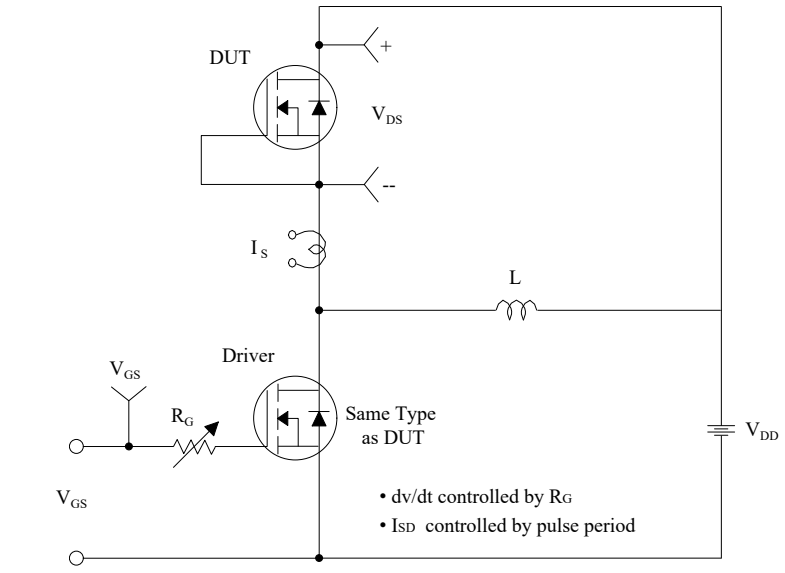
Unclamped Inductive Switching Test Circuit & Waveforms

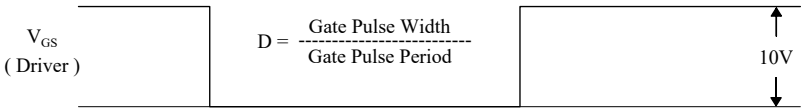


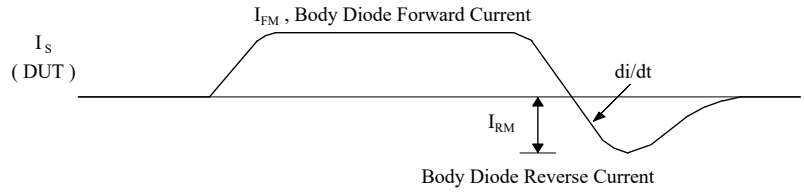
$$E_{AS} = \frac{1}{2} L_L I_{AS}^2$$

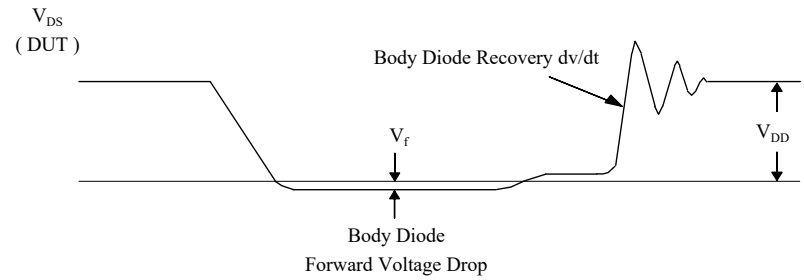


Peak Diode Recovery dv/dt Test Circuit & Waveforms









X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET ***category:***

Click to view products by Maplesemi ***manufacturer:***

Other Similar products are found below :

614233C 648584F IRFD120 IRFF430 JANTX2N5237 2N7000 FCA20N60_F109 FDZ595PZ AOD464 2SK2267(Q) 2SK2545(Q,T) 405094E 423220D MIC4420CM-TR VN1206L 614234A 715780A SSM6J414TU,LF(T 751625C PSMN4R2-30MLD TK31J60W5,S1VQ(O 2SK2614(TE16L1,Q) DMN1017UCP3-7 EFC2J004NUZTDG FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE2384 NTE2969 NTE6400A DMN2080UCB4-7 DMN61D9UWQ-13 US6M2GTR DMN31D5UDJ-7 SSM6P54TU,LF DMP22D4UFO-7B IPS60R3K4CEAKMA1 DMN1006UCA6-7 DMN16M9UCA6-7 STF5N65M6 STU5N65M6 C3M0021120D DMN13M9UCA6-7 BSS340NWH6327XTSA1 MCM3400A-TP DMTH10H4M6SPS-13 IRF40SC240ARMA1 IPS60R1K0PFD7SAKMA1 IPS60R360PFD7SAKMA1 IPS60R600PFD7SAKMA1